

<b>Notice of References Cited</b>	Application/Control No. 10/651,695	Applicant(s)/Patent Under Reexamination ZANZIG ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

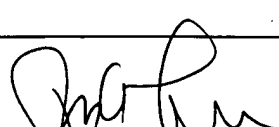
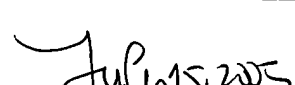
**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,573,412 B1	06-2003	Hogan et al.	568/616
	B	US-5,798,408 A	08-1998	Zanzig et al.	524/505
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	K	US-			
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	M	US-			

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	N	EP 985 554 A1	03-2000	Europe	Halasa et al.	B60C 1/00
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	 

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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